





**30V P-CHANNEL ENHANCEMENT MODE MOSFET** 

#### **Product Summary**

V <sub>(BR)DSS</sub>	R <sub>DS(on)</sub>	I <sub>D</sub> T <sub>A</sub> = 25°C		
-30V	25mΩ @ V <sub>GS</sub> = -10V	-16.1A		
	41mΩ @ V <sub>GS</sub> = -4.5V	-12.5A		

## **Description and Applications**

This new generation MOSFET has been designed to minimize the onstate resistance ( $R_{DS(on)}$ ) and yet maintain superior switching performance, making it ideal for high efficiency power management applications.

- Backlighting
- DC-DC Converters
- Power management functions

#### **Features and Benefits**

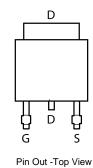
- Low on-resistance
- Fast switching speed
- "Green" component and RoHS compliant (Note 1)

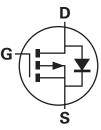
#### **Mechanical Data**

- Case: TO252-3L
- Case Material: Molded Plastic, "Green" Molding Compound. UL Flammability Classification Rating 94V-0 (Note 1)
- Moisture Sensitivity: Level 1 per J-STD-020D
- Terminals Connections: See Diagram
- Terminals: Matte Tin Finish annealed over Copper leadframe. Solderable per MIL-STD-202, Method 208
- Marking Information: See Below
- Ordering Information: See Below
- Weight: 0.33 grams (approximate)



Top View





Equivalent Circuit

#### Ordering Information (Note 1)

Product	Marking	Reel size (inches)	Tape width (mm)	Quantity per reel
DMP3025LK3-13	P3025L	13	16	2,500

Note: 1. Diodes, Inc. defines "Green" products as those which are Eu RoHS compliant and contain no halogens or antimony compounds; further information about Diodes Inc.'s "Green" Policy can be found on our website. For packaging details, go to our website.

## **Marking Information**





#### **Maximum Ratings** @T<sub>A</sub> = 25°C unless otherwise specified

Characteristic			Symbol	Value	Unit	
Drain-Source voltage			V <sub>DSS</sub>	-30	V	
Gate-Source voltage			V <sub>GS</sub>	±20	V	
Continuous Drain current		(Note 3)	I <sub>D</sub>	-16.1		
	$V_{GS} = 10V$	T <sub>A</sub> =70°C (Note 3)		-12.9	А	
		(Note 2)		-10.6		
Pulsed Drain current	V <sub>GS</sub> = 10V	(Note 4)	I <sub>DM</sub>	-41.9	А	
Continuous Source current (Body diode) (Note 3)		Is	-12.6	А		
Pulsed Source current (Body diode) (Note 4)		I <sub>SM</sub>	-41.9	А		

# Thermal Characteristics @T<sub>A</sub> = 25°C unless otherwise specified

Characteristic	Symbol	Value	Unit		
	(Note 2)		4.3 34.5		
Power dissipation Linear derating factor	(Note 3)	PD	10.0 80.0	₩ mW/°C	
	(Note 5)	-	2.15 17.2		
	(Note 2)		29.0		
Thermal Resistance, Junction to Ambient	(Note 3)	$R_{ ext{ heta}JA}$	12.5		
	(Note 5)		58.0	°C/W	
Thermal Resistance, Junction to Lead (Note 6)		R <sub>θJL</sub>	1.02		
Operating and storage temperature range		T <sub>J</sub> , T <sub>STG</sub>	-55 to 150	°C	

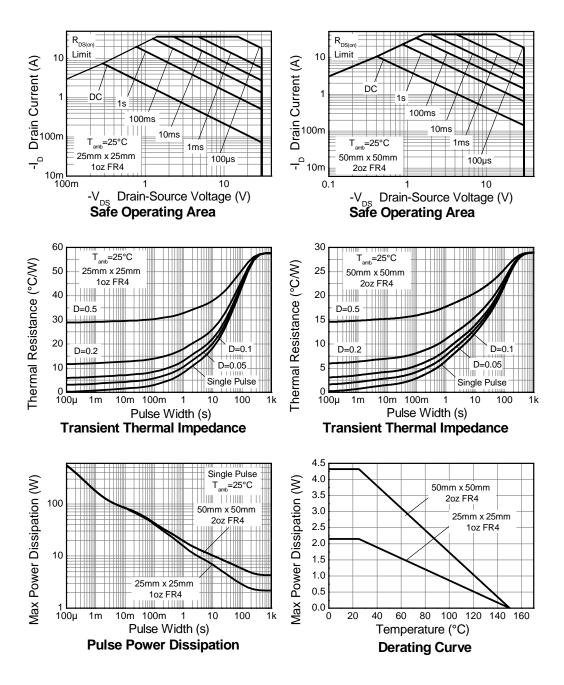
Notes: 2. For a device surface mounted on 50mm x 50mm x 1.6mm FR4 PCB with high coverage of single sided 2oz copper, in still air conditions; the device is measured when operating in a steady-state condition.

3. Same as note 2, except the device is measured at t  $\leq$  10 sec. 4. Same as note 2, except the device is pulsed with D = 0.02 and pulse width 300 µs. The pulse current is limited by the maximum junction temperature. 5. For a device surface mounted on 25mm x 25mm x 1.6mm FR4 PCB with high coverage of single sided 1oz copper, in still air conditions; the device is measured when operating in a steady-state condition.

6. Thermal resistance from junction to solder-point (at the end of the drain lead).



#### **Thermal Characteristics**







## Electrical Characteristics @T<sub>A</sub> = 25°C unless otherwise specified

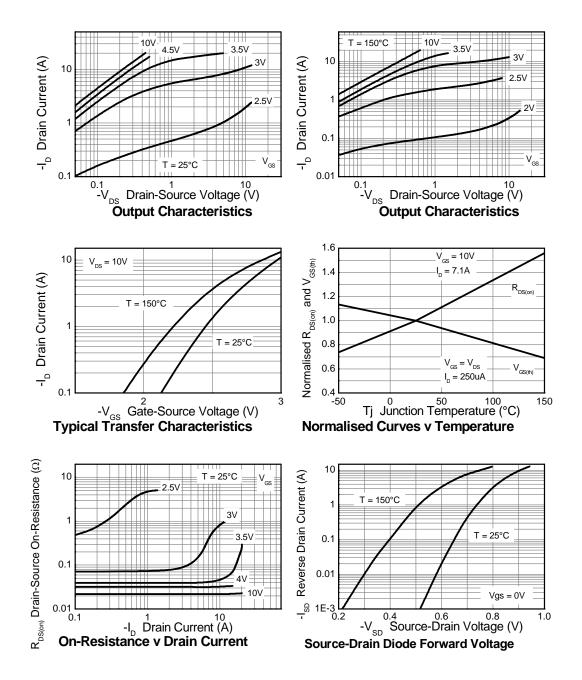
Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition	
OFF CHARACTERISTICS							
Drain-Source Breakdown Voltage	BV <sub>DSS</sub>	-30		_	V	$I_D = -250 \mu A$ , $V_{GS} = 0 V$	
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	_		-0.5	μA	V <sub>DS</sub> = -30V, V <sub>GS</sub> = 0V	
Gate-Source Leakage	I <sub>GSS</sub>	_		±100	nA	$V_{GS}=\pm 20V, V_{DS}=0V$	
ON CHARACTERISTICS							
Gate Threshold Voltage	V <sub>GS(th)</sub>	-1.0		-3.0	V	$I_D$ = -250 $\mu$ A, $V_D$ S= $V_G$ S	
Static Drain-Source On-Resistance (Note 7)	Decement			0.025	Ω	V <sub>GS</sub> = -10V, I <sub>D</sub> = -7.1A	
	R <sub>DS</sub> (ON)	_		0.041	12	$V_{GS}$ = -4.5V, I <sub>D</sub> = -5.5A	
Forward Transconductance (Notes 7 & 8)	<b>g</b> fs	_	18.6		S	V <sub>DS</sub> = -15V, I <sub>D</sub> = -7.1A	
Diode Forward Voltage (Note 7)	V <sub>SD</sub>	_	-0.80	-1.2	V	I <sub>S</sub> = -1.7A, V <sub>GS</sub> = 0V	
Reverse recovery time (Note 8)	t <sub>rr</sub>		16.2		ns		
Reverse recovery charge (Note 8)	Q <sub>rr</sub>	_	10		nC	-I <sub>S</sub> = -2.2A, di/dt= 100A/μs	
DYNAMIC CHARACTERISTICS (Note 8)							
Input Capacitance	C <sub>iss</sub>	_	1678	_	pF		
Output Capacitance	C <sub>oss</sub>	_	303	_	pF	<sup>⊣</sup> V <sub>DS</sub> = -15V, V <sub>GS</sub> = 0V ⊣f= 1MHz	
Reverse Transfer Capacitance	Crss	_	178		pF		
Total Gate Charge	Qg	_	16.5	_	nC	V <sub>GS</sub> = -4.5V	
Total Gate Charge	Qg	—	31.6	_	nC	V <sub>DS</sub> = -15V,	
Gate-Source Charge	Q <sub>gs</sub>	_	4.3	_	nC	V <sub>GS</sub> = -10V I <sub>D</sub> = -7.1A	
Gate-Drain Charge	Q <sub>gd</sub>	_	6.2	_	nC		
Turn-On Delay Time (Note 9)	t <sub>D(on)</sub>	_	3.5	_	ns		
Turn-On Rise Time (Note 9)	tr	_	4.9	_	ns	V <sub>DD</sub> = -15V, V <sub>GS</sub> = -10V	
Turn-Off Delay Time (Note 9)	t <sub>D(off)</sub>	_	44	_	ns	$I_D$ = -1A, $R_G \cong 6.0\Omega$	
Turn-Off Fall Time (Note 9)	t <sub>f</sub>	_	23	_	ns	7	

Notes:

Measured under pulsed conditions. Pulse width ≤ 300µs; duty cycle ≤ 2%
For design aid only, not subject to production testing.
Switching characteristics are independent of operating junction temperatures.

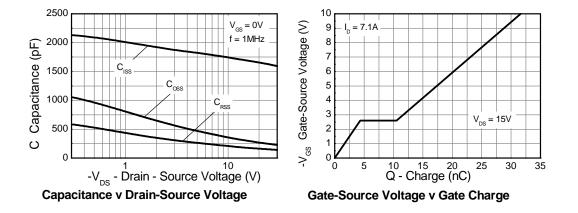


# **Typical Characteristics**

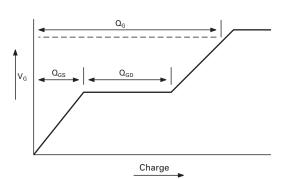




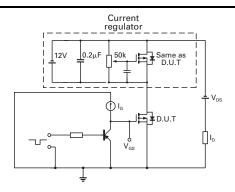
## **Typical Characteristics - continued**



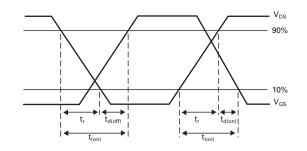
**Test Circuits** 



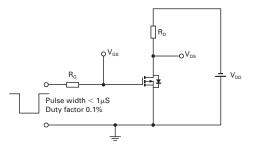
Basic gate charge waveform



Gate charge test circuit





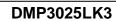


Switching time test circuit

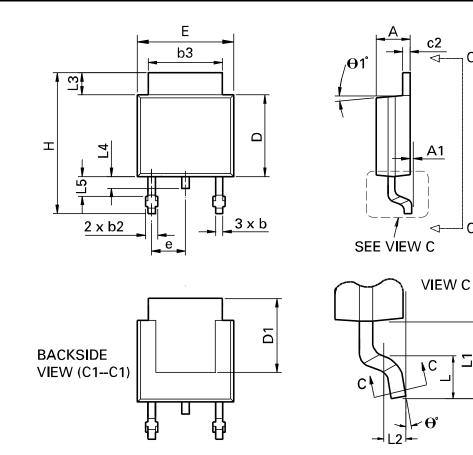


C1

C1



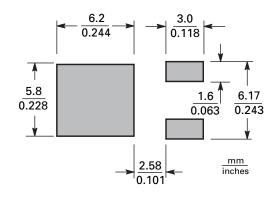
## **Package Outline Dimensions**



DIM	Inches		Millimeters		DIM	Inches		Millimeters	
	Min	Max	Min	Max		Min	Max	Min	Max
А	0.086	0.094	2.18	2.39	е	0.090 BSC		2.29 BSC	
A1	-	0.005	-	0.127	н	0.370	0.410	9.40	10.41
b	0.020	0.035	0.508	0.89	L	0.055	0.070	1.40	1.78
b2	0.030	0.045	0.762	1.14	L1	0.108 REF		2.74 REF	
b3	0.205	0.215	5.21	5.46	L2	0.020 BSC		0.508 BSC	
с	0.018	0.024	0.457	0.61	L3	0.035	0.065	0.89	1.65
c2	0.018	0.023	0.457	0.584	L4	0.025	0.040	0.635	1.016
D	0.213	0.245	5.41	6.22	L5	0.045	0.060	1.14	1.52
D1	0.205	-	5.21	-	θ1°	0°	10°	0°	10°
E	0.250	0.265	6.35	6.73	θ°	0°	15°	0°	15°
E1	0.170	-	4.32	-	-	-	-	-	-



## **Suggested Pad Layout**



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